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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/552,576	FURUUCHI, MIKIO	
Examiner	Art Unit	
Kavel P. Singh	3651	

SEARCHED			
Class	Subclass	Date	Examiner
198	594,595,8 12,814,81 7	3/14/2007	KPS
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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feeder, feed device	3/14/2007	KPS
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